

Network for Computational Nanotechnology (NCN)

Berkeley, Univ.of Illinois, Norfolk State, Northwestern, Purdue, UTEP

Introduction to the NEMO3D Tool

Gerhard Klimeck













Problem:

Nanoscale device simulation requirements:

- Cannot use bulk / jellium descriptions, need description atom by atom
 => use pseudo-potential or local orbitals
- Consider finite extend, not periodic => local orbital approach
- Bonds in semiconductors are stable!
 => Do not need ab-initio methods!
- Need to include about one million atoms.
 => need massively parallel computers
- The design space is huge:.
 => need a design tool

Approach:

- Use local orbital description for individual atoms in arbitrary crystal / bonding configuration
 - Use s, p, and d orbitals.
 - Use genetic algorithm to determine material parameter fitting
- Compute mechanical strain in the system.
- Develop efficient parallel algorithms to generate eigenvalues/vectors of very large matrices



NEMO 3-D Technical Approach





Demonstration / Capability / Impact:

- 52 million atom electronic structure (101nm)³.
- Quantum dots, nanowires, quantum computing...

Approach:

- Use local orbital description for individual atoms in arbitrary crystal / bonding configuration
 - Use s, p, and d orbitals.
 - Use genetic algorithm to determine material parameter fitting
- Compute mechanical strain in the system.
- Develop efficient parallel algorithms to generate eigenvalues/vectors of very large matrices





Atomistic Tight-Binding Hamiltonian



Crystalline Structure









Nearest-Neighbor sp3d5s* Model





Modeling Strain Bond Lengths and Angles Change











NEMO 3-D Calculation Flow – VFF Strain Model





Strain Impact on Electronic Structure

- Strain → Changes bond lengths/angles → deforms crystals
- Band edges are shifted and degeneracy of HH-LH is lifted
- Strain impact on electronic structure:

Conduction Band $\rightarrow E_c = E_{c0} + a_c(\epsilon_{xx} + \epsilon_{yy} + \epsilon_{zz})$ Valence Band $\rightarrow E_{HH/LH} = E_{HH0/LH0} + a_v(\epsilon_{xx} + \epsilon_{yy} + \epsilon_{zz}) \pm 0.5b_v(\epsilon_{xx} + \epsilon_{yy} - 2\epsilon_{zz})$

where $a_c = -5.08eV$, $a_v = 1.0eV$ and $b_v = -1.8eV$ for InAs







NEMO 3-D Calculation Flow -Piezo-Electric Model



Strain tensor → Polarization

$$P_{1} = 2e_{14} \begin{pmatrix} \varepsilon_{yz} \\ \varepsilon_{xz} \\ \varepsilon_{xy} \end{pmatrix}$$

$$P_{2} = 2B_{114} \begin{pmatrix} \varepsilon_{xx} \varepsilon_{yz} \\ \varepsilon_{yy} \varepsilon_{xz} \\ \varepsilon_{zz} \varepsilon_{xy} \end{pmatrix} + 2B_{124} \begin{pmatrix} \varepsilon_{yz} (\varepsilon_{yy} + \varepsilon_{zz}) \\ \varepsilon_{xz} (\varepsilon_{zz} + \varepsilon_{xx}) \\ \varepsilon_{xy} (\varepsilon_{xx} + \varepsilon_{yy}) \end{pmatrix} + 4B_{156} \begin{pmatrix} \varepsilon_{xz} \varepsilon_{xy} \\ \varepsilon_{yz} \varepsilon_{xy} \\ \varepsilon_{yz} \varepsilon_{xz} \end{pmatrix}$$

Polarization \rightarrow Charge density

$$\rho_{piezo}(r) = -\nabla . P$$
$$P = P_1 + P_2$$

Charge density \rightarrow Potential

$$\rho_p(r) = \varepsilon_0 \nabla . [\varepsilon_s(r) \nabla V_p(r)]$$



RDUE



NEMO 3-D Calculation Flow – Electronic Structure Model



- Real-size QD typically involves multimillion atoms.
- sp³d⁵s* TB requires 20 bases per each atom with consideration of spinorbit couplings → (Natomx20) by (Natomx20) Hamiltonian.
- Need to obtain interior spectrum eigenstates
- NEMO 3-D: Designed from the bottom up to be parallel: MPI.
- NEMO 3-D code has been tested to run on (almost) any HPC cluster

. .







• Divide Simulation domain into slices.

INCN project

nor

- Communication only from one slice to the next (nearest neighbor)
- Communication overhead across the surfaces of the slices.
- Limiting operation: complex sparse matrix-vector multiplication
- Enable Hamiltonian storage or re-computation on the fly.



- Electronic structure needs eigenvalues and eigenvectors. Matrix is Hermitian
- NEMO 3-D methods:
 - Standard 2-pass Lanczos
 - PARPACK about 10x slower
 - Folded Spectrum Method (Zunger), also typically slower than Lanczos





From Beowulf Concept (1998 JPL, Tom Sterling) to Commodity Products in 4 Generations

Hyglac (1997) 16 Pentium Pros 200MHz 128 MB RAM per node 2 GB total 5GB Disc per node 80 GB total 100 Mb/s ethernet crossbar Linux, MPI 3.2GFlops

Gordon Bell Prize 1997

<u>Nimrod (1999)</u> 32 Pentium IIIs 450MHz 512 MB RAM per node *16 GB total* 8GB Disc per node *256 GB total* 100 Mb/s ethernet crossbar Linux, MPI 14.4 GFlops Pluto (2001) 64 Pentium IIIs 800MHz dual CPUs 2 GB RAM per node 64 GB total 10 GB Disc per node 320 GB total 2 Gb/s Myricom crossbar Linux, MPI 51.2 GFlops 66 Xserve G4 1GHz 1GB RAM per node 33 GB total 60 GB Disc per node 2 TB total 100 Mb/s ethernet crossbar MAC OS X, MPI 495GFlops

NewYork (2002)



















Recomputed Hamiltonian



2003 <u>32 node, G5 Apple cluster</u> 2GB RAM, Dual Gigabit Ethernet.







Parallelization Benchmarks





Parallelization Benchmarks

online simulation and more

Scaling to 8,192 processors in NEMO3D

Is a bit of a cheat!

2007 IBM BGL, Cray XT3, Intel Clusters, IBM JS21



Need a 2D and 3D Decompositions







NEMO Development and Scalability Study Sunhee Lee, Hoon Ryu, Gerhard Klimeck

Objective

- Run large atomistic electronic structure simulations in minutes
- Represent realistically large structures atomistically
- Utilize available peta-scale computers

Approach

- Improve decomposition parallelism
- Include self-consistent calculations

Performance / Impact

- Strong scaling of 3D decomposition
 => have overcome 1D limitation
- Utilized over 10,000 cores for realistic simulation domain size
- Expecting dramatic reduction of simulation time
 => 10hours to 20 minutes
- Published in SCIDAC proceedings, 2009, Haley, Lee et al.



Proof of Concept Extraction of Targeted Interior Eigenstates









Proof of Concept Extraction of Targeted Interior Eigenstates



Unique and targeted eigenstates of correct symmetry can be computed in all electronic computational domains



INCN project

nanot





NEMO 3-D Technical Capabilities





Demonstration / Capability / Impact:

- 52 million atom electronic structure (101nm)³.
- Quantum dots, nanowires, quantum computing..

Capabilities:

- Arbitrary 3D zincblende, wurzite crystals
- Strain in Valence Force Fields
- Piezo Electricity through potential perturbation
- Electronic Structure with empirical tight binding

Applications:

- InAlGaAs/GaAs quantum dots
- Valley splitting in Silicon
- Alloy disorder in bulk, QD, nanowires
- Single impurities in Si 19





Multi-Million Atom Simulation of Quantum States and Transport in Realistically Extended Devices in Silicon for Quantum Computing

Gerhard Klimeck, Rajib Rahman, S-H Park, Hoon Ryu, Sunhee Lee, Muhammad Usman, Neerav Kharche, **Purdue**

Lloyd Hollenberg, Melbourne

Sven Rogge, G. Lansbergen, Delft

Michelle Simmons, Bent Weber, S. Mahapatra, UNSW

Rajib Rahman, Richard Muller, Sandia







Industrial Device Trends and Challenges



Observations:

- 3D spatial variations on nm scale
- Potential variations on nm scale
- New channel materials (Ge, III-V)

Questions / Challenges

- Strain ?
- Quantization?
- Crystal orientation?
- Atoms are countable; does granularity matter? Disorder?
- New material or new device?

Assertions of importance

- High bias / non-equilibrium
- Quantum mechanics
- Atomistic representation
 - » Band coupling, non-parabolicity, valley splitting
 - » Local (dis)order, strain and orientation





Quantum Transport far from Equilibrium



The first 300K Quantum Transport Device Controlled at Atomic Monolayers



Conduction band diagrams for different voltages and the resulting current flow



nanoli

Gerhard Klimeck

Sb1780 Sb 1781 R=8.8Ω Nominal Size 07/20/07 ml (Type) (08/17/08)

12 different I-V curves: 2 wafers, 3 mesa sizes PVR – Peak-to-Valley-Ratio 1994: Best experiment PVR=80

 => On-Off-Ratio should to be >1,000
 1994: What is the valley current physics?
 1997: Can overlay experiment and theory. What are the key insights?
 Atomistic device resolution (2-5nm dim.)
 Extended contacts with scattering
 Extended electrostatics
 First industrial NEGF device simulator

NEMO 3-D Technical Approach





Problem:

Nanoscale device simulation requirements:

- Cannot use bulk / jellium descriptions, need description atom by atom
 => use pseudo-potential or local orbitals
- Consider finite extend, not periodic => local orbital approach
- Bonds in semiconductors are stable!
 => Do not need ab-initio methods!
- Need to include about one million atoms.
 => need massively parallel computers
- Tight binding in a design tool: NEMO3D



Demonstration / Capability / Impact:

- 52 million atom electronic structure (101nm)³.
- Quantum dots, nanowires, quantum computing..



Quantum States in Silicon – Impurities / Quantum Dots







Nanoelectronic Modeling (NEMO) for High Fidelity Simulation of Solid-State Quantum Computing Gates

^{#^{*,2}, Rahman^{1,6}, Park¹, Ryu¹, Lee¹, Wellard³, Cole³, Hollenberg³, Lansbergen⁴, Rogge⁴, Simmons⁵}

¹Purdue, ²JPL, ³Melbourne, ⁴Delft, ⁵Sydney, ⁵Sandia

Weber⁵, Pok⁵, Muller

Objective

- Narrow experimental qubit parameter space
- Development of a comprehensive suite of modeling tools for solid state qubit devices.
- Atomic level material description.
- Model both spin and charge coherent devices.
- Magnetic field effect on electronic structure and state coherence.
- Compute interactions.

nanoli

Objective Approach

- Leverage about 50,000 hours NEMO 1-D and 20,000 hours NEMO 3-D development.
- Model semicond. Quant. Comput. Syst.
 - Si on SiGe (Wisconsin / Eriksson)
 - P in Si (Australia / Dzurak)
 - Si QD in SiGe (Purdue / Rokhinson)
- Atomistic of treatment semiconductors.
- Incorporate many-body effects through Hartree & configuration interaction.
 PURDUE Gerhard Klimeck



• Dense impurities in Si Wire – ongoing - exp









Nanoelectronics • Architectures





Multi-Million Atom Simulation of Quantum States in Realistically Extended Devices in Silicon

- Motivation
- NEMO Numerical Engine
- Valley splitting
 - »Si quantum wells
 - »Si Quantum Dots
- Single impurities in Si
 »Metrology impurity identification
 »Wavefunction mapping
 »g-factor engineering
 »CTAP
- Dense impurities in Si Si:P
 »Infinite sheets
 »Infinite wires
 »Gating, transport through wires
 - »Impurity-based quantum dots



Valley-splitting in strained Silicon

quantum wells on a miscut substrate

Authors: <u>Neerav Kharche</u>, Marta Prada, Timothy Boykin, and Gerhard Klimeck

Spin based quantum computing in Si/SiGe heterostructures



Potential problem: Valley degeneracy

• Six-fold degenerate valleys lead to spin decoherence

PURDUE Gerhard Klimeck

Biaxial strain splits **six-fold** valleydegeneracy into

- Lower two-fold degeneracy
- Higher four-fold degeneracy

 k_y k_z k_x

• Lowest two-fold degenerate valleys split in the presence of sharp confinement potentials in QWs.



•Valley-splitting is a critical design parameter for QC devices.

Ultra Thin Body SOI:

A traditional Quantum Well?



nanoHUB

NCN project

Most basic quantum mechanical problem: Particle in a box!

Expect / Remember:

- State quantization
- 2 counter-propagating states
- 1 bound state

0.5



PURDUE Gerhard Klimeck



PURDUE

Gerhard Klimeck

Quantum Wells

Special Considerations in Si







- Strained Si QW, Hardwall BCs
- Oscillations with Monolayers (decay as ML⁻³) published analytical results





Splitting Behavior With

Quantum Well Width and Electric Field

- Strained Si QW, Hardwall BCs
- Oscillations with Monolayers
- Oscillations decay with increasing Field
- Decay significant once drop/ML is of order zero-field splitting





Splitting Behavior With

Quantum Well Width and Electric Field

- Strained Si QW, Hardwall BCs
- Oscillations with Monolayers

 $\square \square \square \square \square$

 E_{21} [meV]

- Oscillations decay with increasing Field
- Decay significant once drop/ML is of order zero-field splitting
 - For fixed *L*, splitting linear at high field, nonlinear at low field





Splitting Behavior With

Quantum Well Width and Electric Field

- Strained Si QW, Hardwall BCs
- Oscillations with Monolayers

INCN project

 E_{21} [meV]

- Oscillations decay with increasing Field
- Decay significant once drop/ML is of order zero-field splitting
- For fixed L, splitting linear at high field, nonlinear at low field







Valley Splitting Physics Flat Quantum Well




tilted quantum well



PURDUE Gerhard Klimeck

INCN Project

nano

ideal tilted quantum well - zero valley splitting



NCN project

nanoli



need symmetry breaking to induce valley splitting



magnetic field confinement



INCN project

nanoli

Other symmetry breaking mechanisms



INCN project

nanot



step roughness



Kharche et al. Appl. Phys. Lett. 90, 092109 (2007)

PURDUE Gerhard Klimeck

NCN project

nanoi



Effect of disorder on valley-splitting step roughness and alloy disorder



Kharche et al. Appl. Phys. Lett. 90, 092109 (2007)

PURDUE Gerhard Klimeck



Effect of disorder on valley-splitting step roughness and alloy disorder





Quantum Wells

Special Considerations in Si



Envelope:

k_{1/2} ~ a/na

a: lattice constant n: QW layers L=na

Phase control:

k_m ~ 0.85 a/a Depends on atomic overlaps



Rapid oscillation, $k_m \Rightarrow$ sensitivity to atomic details at the interface

Have demonstrated as critical understanding: ⇒Disorder in Barriers: Alloy and Step Appl. Phys. Lett. **90**, 092109 (2007)

Analytical expressions for structures with fields: JAP, Vol. 97, pg. 113702 (2005).

Analytical expressions for finite barriers: Phys. Rev. B, Vol. 77, 245320 (2007)

Multi-Million Atom Simulation of Quantum States in Realistically Extended Devices in Silicon

- Motivation
- NEMO Numerical Engine
- Valley splitting
 »Si quantum wells
 »Si Quantum Dots
- Single impurities in Si
 »Metrology impurity identification
 »Wavefunction mapping
 »g-factor engineering
 »CTAP
- Dense impurities in Si Si:P
 »Infinite sheets
 »Infinite wires
 - »Gating, transport through wires
 - »Impurity-based quantum dots



Silicon Quantum Dots in SiGe Matrix

online simulation and more

Srikant Srinivasan, Leonid Rokhinson, Gerhard Klimeck

Objective:

- Prepare experiments (Rokhinson)
- Study realistic/large embedded Si QD
- Aid in understanding and design, buffer randomness, interfaces, Valley Splitting
- Explore size and disorder dependence

Approach:

- No NEMO 3D modifications needed
- Strain penetrates 40nm into SiGe => 50 million atom strain sim..
- Typically 365.000 atoms in electronic domain





Results / Impact:

 Fluctuations with quantum dot size like 1D











Wavefunction Penetration



Valley Splitting is an INTERFACE DOMINTED phenomenon



INCN project

nanoli



Wavefunction Penetration Analytical Expressions



Valley Splitting is an INTERFACE DOMINTED phenomenon Analytical formulas help, but cannot really guide the decision process

INCN Project

nanot



Silicon Quantum Dots in SiGe Matrix

Srikant Srinivasan, Leonid Rokhinson, Gerhard Klimeck

Objective:

nanot

- Prepare experiments (Rokhinson)
- Study realistic/large embedded Si QD
- Aid in understanding and design, buffer randomness, interfaces, Valley Splitting
- Explore size and disorder dependence

Approach:

- No NEMO 3D modifications needed
- Strain penetrates 40nm into SiGe => 50 million atom strain sim..
- Typically 365.000 atoms in electronic domain





Results / Impact:

- Fluctuations with quantum dot size like 1D in short simensions
- VS controllable in long dimensions
- Disorder and Order matters
- Analytical formulas cannot provide quantitative experimental guidance APL, Vol. 93, pg. 112102 (2008),

Multi-Million Atom Simulation of Quantum States in Realistically Extended Devices in Silicon

- Motivation
- NEMO Numerical Engine
- Valley splitting
 »Si quantum wells
 »Si Quantum Dots
- Single impurities in Si
 »Metrology impurity identification
 »Wavefunction mapping
 »g-factor engineering
 »CTAP
- Dense impurities in Si Si:P
 »Infinite sheets
 »Infinite wires
 »Gating, transport through wires
 - »Impurity-based quantum dots



Metrology with multimillion atom simulations Excited States are Critical!

Objective:

Support single impurity spectroscopy



Approach:

- Experiments & NEMO3D (on 3 continents!) **Results / Impact:**
- Identify Impurities as As not P
- Determine depth of impurities from interface
- Nature Physics, V4, p 656 (2008)



Mapping Donor Wavefunctions

Seung Hyun Park, Rajib Rahman, Gerhard Klimeck, Lloyd Hollenberg

Need for high precision control of WF in QC

nanot



Hyperfine Interaction Tensor (A) $A_{ij} = \gamma_I \gamma_S \hbar^2 \left(\frac{8\pi}{3} |\Psi(0)|^2 \delta_{ij} + \left\langle \Psi \left| \frac{3x_i x_j - r^2 \delta_{ij}}{r^5} \right| \Psi \right\rangle \right)$

 $\gamma_{I,S}$ =gyromagnetic ratio, $x_{ij} = (x,y,z)$

Originally measured in 1969

ESR Experiments can measure A_{ii}

➔ Indirect measure of WF

Park, PRL (2009) arXiv:0902.1515v1 Gerhard Klimeck Stark Shift Spectrum of a P donor at 3.8nm from an oxide interface in Si



Corresponding Hyperfine Maps in the forms of B_{yy} tensor component



Spin-Orbit Stark Effect in Donors

Rajib Rahman, Seung Hyun Park, Timothy B. Boykin, Gerhard Klimeck, Sven Rogge, Lloyd Hollenberg

Objective:

 $\square \square \square \square \square$

- Study Stark Shift of the g-factor for an isolated donor w.r.t. expt in Si and Ge.
- g-factor shift for interface-donor system.

IT NCN project

- Probes spin-orbit effects with electric fields and symmetry change.
- Effect of relative orientations of B and E field.

Approach:

- The 20 band nearest neighbor sp3d5s* spin model captures SO interaction of the host.
- Same atom p orbital energy between spin orbitals.
- g-factor obtained from orbital and spin angular momentum operators.
- Donor wfs with E-field are obtained from NEMO

Results / Impact:

- Quadratic Stark coefficient from TB agrees with measured value in magnitude.
- Relative E and B orientations seem to affect gfactor shift. Linear for shallow donors.
- Stark shift of Zeemann splitting may become comparable to hyperfine shift at modest B fields.
- Understanding of the B field dynamics of the donor electron.

WF and g-factor of donor engineering by EM





Coherent Transport Adiabatic Passage (CTAP)

an NCN project nanoHUB

Rajib Rahman, Seung Hyun Park, Jared Cole, Andrew Greentree, Richard P. Muller, Gerhard Klimeck, Llovd Hollenberg

Objective:

- Investigate CTAP in realistic setting.
- Include Si full band-structure, TCAD gates, interfaces, excited states, cross-talk.
- Verify that adiabatic path exists: 3 donor device.

Approach:

- TCAD gates coupled with a 3 donor TB. Hamiltonian to obtain molecular states.
- Simulate "small" 3 M atom device rapidly to demonstrate concept
- Compute time of 4-5 hours on 40 procs.
- Many bias configurations to fine tune gate voltages to explore the CTAP. regime.

Results / Impact:

- 15nm separated donors to explore rapidly => significant gate cross talk => Determination of gate bias control tedious
- Demonstrated that the CTAP regime exists for a 3 donor test device.

Schematic of the CTAP device



CTAP Protocol

Vb.

-0.01325 V

Vs.

wf3

wf2

wf1



CTAP

Published in Phys. Rev. B. 80, 035302 (2009)

Coherent Transport Adiabatic Passage (CTAP)

Rajib Rahman, Seung Hyun Park, Jared Cole, Andrew Greentree, Richard P. Muller, Gerhard Klimeck, Lloyd Hollenberg



Results / Impact:

- 15nm separated donors to explore rapidly
 => significant gate cross talk
 => Determination of gate bias control tedious
- Demonstrated that the CTAP regime exists for a 3 donor test device.

Schematic of the CTAP device



Published in Phys. Rev. B. 80, 035302 (2009)

Coherent Transport Adiabatic Passage (CTAP)

Rajib Rahman, Seung Hyun Park, Jared Cole, Andrew Greentree, Richard P. Muller, Gerhard Klimeck, Lloyd Hollenberg



NCN project

Results / Impact:

nanotil

- 15nm separated donors to explore rapidly
 => significant gate cross talk
 => Determination of gate bias control tedious
- Demonstrated that the CTAP regime exists for a 3 donor test device.
- Initial straggle case in high cross talk regime indicates a different bias pathway
- Indicative of general need for individual characterization of qubit transport mechanisms
- Simulations enable development of bias control algorithms in actual experiments (e.g. charge sensing)

Schematic of the CTAP device





Next: project NEMO3D results on to 3x3 matrix and get V_{qate} dependence of elements

Sandia / Purdue / Melbourne

Multi-Million Atom Simulation of Quantum States in Realistically Extended Devices in Silicon

- Motivation
- NEMO Numerical Engine
- Valley splitting
 »Si quantum wells
 »Si Quantum Dots
- Single impurities in Si
 »Metrology impurity identification
 »Wavefunction mapping
 »g-factor engineering
 »CTAP

Dense impurities in Si – Si:P
 »Infinite sheets
 »Infinite wires
 »Gating, transport through wires
 »Impurity-based quantum dots





PURDUE

Atomic-Precision Doping by STM



Slide courtesy of Simmons Group

Highly δ-Doped Si Devices

Motivation:

nanot

 Understand available experimental data

INCN project

Guide experimental set-ups

Problems:

- Validate / confirm our approach to other theories
- Incorporate extended devices
- Understand metallic behavior
- •Explain effects of
 - Doping density
 - •Wire size / orientation
 - •Electrical gating

Approach:

- NEMO 3D with tight binding
- Charge-potential self-consistency

• P δ-doped Si (Si:P) Wire



examine large contacts first

• Si:P Planar quantum Dots





Contact Regions - Infinite Square Well



- Extremely thin P-doped layer in Si bulk.
- Confinement happens with impurity potential along [001].
- Need approximation for efficient modeling \rightarrow Quantum Well Approach.
- Assume periodic boundary condition along [100]/[010]

PURDUE Gerhard Klimeck

Band Projection in [100] Si:P Quantum Wells

• 3D→2D→1D projection of Si [100] nanowire

NCN project

nanolti



Charge-Potential Self-Consistency

- $\frac{1}{4}$ ML Doping = 2 impurity ions in the super cell ~ 1.7x10¹⁴ (cm²)
- Metal-like system : Charge-Potential Self-consistency

INCN project

 $\square \square \square \square \square$

Schrödinger-Poisson + Exchange/Correlation with LDA approach









NCN project

nanoH

online simulation and more

Case	Γ1 (meV)	EF (meV)
Carter et al	- 540	- 130
Qian <i>et al</i>	- 410	- 99
Ours	- 415	- 111
0		





Si:P Nano-Wires



G

D

• T~ 1.2(K). Doping Constant ~ 1/4ML

Problem to be solved

- Gate-dependent S-to-D Conduction Behavior
- Conduction through Donor-bands

PURDUE Gerhard Klimeck





Super-cell Approximation

Need to reduce computational domain size.



Band projection in [100] Si:P wires

• 3D→2D→1D projection of Si [100] nanowire

NCN project

nanoh



URDUE Gerhard Klimeck
Band projection in [110] Si:P wires

• $3D \rightarrow 2D \rightarrow 1D$ projection of Si [110] nanowire

nanoh





Band Projection in [100]/[110] Si:P Quantum Wire



Crystal direction Dependence [100],[110],[111]



(B) X=[110]

0000

0000

(C) X=[111]

0

 $\circ \circ \phi$

(A) X=[100]

0

0 0

0 0

0 0

0,01

(A) 2DR	(B) 4DR	(C) 8DR	(D) 16DR		
00	00	00	00	Width D	ependence
00					19 - A 21
0 0	00	00	0 0		
0 0	00	00	00	Dependence of bandstructures on wid	th
0 0	00	00		for [110] transport and 1/4ML doping	
0 0	0 0	00	$\circ \bullet$		
				2DR 4DR 8DR	16DR
0 0	0 0	0 0	0 0		
0 0	00	00	$\circ \bullet$		
0 0	0 0	• 0	• •		
0 0	0 0	00	0 0		
	00	\circ	$\circ \circ$	Si Si	
0 0	• 0	• 0	• •	-400	
	$\circ \circ$			AB	
0 0	0 0	0 0	0 0		
$\circ \bullet$	• •	• 0		-600	
0 0	00	00	00		
0 0	0 0	0 0	0 0		
0 0	0 0	0	$\circ \bullet$	$\overline{00} 0 0.5 1 0 0 0.5 1 0 0 0 0.5 1 0 0 0 0 0 0 0 0 $	0 0.5 1 k(Pl/L,_)
					, ur
0 0	0 0	0 0	0 0		
			\circ	\tilde{E} -1 -1 -1 -1 -1 -1 -1 -1 -1 -1 -1 -1 -1	5 5 10 15 20 25
0 0	0 0	0 0	\bullet \circ	$G(2e^{2}/h)$ $G(2e^{2}/h)$ $G(2e^{2}/h)$	G(2e ² /h)
0 0	00	00	0 0		
0 0	00	00	$\stackrel{\circ}{\circ}$		
0 0	000	00	00		
•	•	•	0 0		
0 0	0 0	0 0	0 0		



Dopant Placement Details

Dependence of bandstructures on dopant profile For [110] transport, 2 dimer row width and 1/64 ML doping



Case1

:Exp 1(e

00

Ó

Dopant Placement Details



• Charge distribution on δ -doping layer





-																																
C	•••	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		
С	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		
С	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		
																																_
С	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	ဂ	
С	••	0	0	0	0	0	0	٥.	0	0	0	0	0	0	0	٥,	0	0	0	٥.	0	0	0	٥.	0	0	0	٥.	0	0	ġ,	
_	:	-				_	_			_						:	1			:				:							S S	
	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	<u>_</u>	0	0	0	0	0	<u> </u>		
0		0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	ယ	
č		0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	2		
C		0	õ	ŏ	õ	ĕ	õ	õ	0	õ	õ	õ	õ	õ	õ	0	õ	õ	õ	0	õ	0	0	õ	0	õ	0	0	0	\sim		
C	0	0	0	0	0	ö	0	ō	0	ō	0	0	Ö	0	0	0	õ	0	0	0	0	0	0	ö	0	0	õ	0	0	õ		
	:			-				-				-												:								
C	0	0	0	o	0	0	0	0	0	0	0	o	0	0	0	0	o	0	0	0	o	0	0	o	0	0	0	o	0	0		
C	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		





0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	C
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	تف
					-								3				3				3				-				-			S
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	o	o	0	P
0	0	σ	0	0	0	0	0	0	σ	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	Ő	0	0	4
•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	
0	0	0	0	۰	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	
																									-							
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	o	0	
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	





Case1:Exp

` (e)

Gerhard Klimeck

Multi-Million Atom Simulation of Quantum States in Realistically Extended Devices in Silicon



»Gating, transport through wires
»Impurity-based quantum dots

Gating Effects on Si:P Nano-Wires





Device Information

- Effective Channel ~ 15nm
- From Gate to Channel ~ 35nm
- T~ 1.2(K). Doping Constant ~ 1/4ML

Problem to be solved

Gate-dependent S-to-D Conduction Behavior

S

Conduction through Donor-bands

PURDUE Gerhard Klimeck

Fermi-Level and Band Alignment

The Local-bandstructure along transport direction.

nQn



Charging Effect on Conduction Property

• We fix # of charge filling => Obtain EF and potential

IT NCN project

nanolti



Transport through impurity bands?

 Charge expands in diameter

• Ellipsoid :

[001]

121ML

[1-10]

[110]

nanot

10nm axis along [1-10] 8nm axis along [001]

Siencapsulation

INCN project

Fransport

Nelectron = 0.80



PURDUE Gerhard Klimeck

. .



Comparison to experiment - Super Cell 1

Channel Conductance



online simulation and more

Channel Conductance



Transport of P δ -doped Si Quantum Wire



Ch Simulate

nanoli



Results – Numerical Experiments :

- Direction dependence:
 - Dispersion (strong)
 - Conductance (weak)
- Doping, width, configurations:
 - Dispersion and conductance (strong)
- Strong gate / charge dependence! **Problems:**
- Need better control over the spatially extended electrostatic potential



Multi-Million Atom Simulation of Quantum States in Realistically Extended Devices in Silicon



»Impurity-based quantum dots



»Number of filled electrons (#e) in the dot

» Correct estimate of the excited spectrum from the Coulomb diamond.

PURDUE Gerhard Klimeck

Multi-Million Atom Simulation of Quantum States in Realistically Extended Devices in Silicon

• Enable:

- »Numerical experiments one could not do otherwise
 - ✓ Experimentally
 - ✓ Analytically

»Realistically extended devices

- »Quantitative explanation of experiments
 - ✓ Valley splitting in quantum wells
 - ✓ Single impurities
 - Not yet Dense impurity channels
- Strain and electrostatics are farreaching into the crystal
- Disorder at the interface is critical
- Valley splitting is interface dominated sensitive to the details of the interface!
- Scattered Impurity placement in dense Si:P systems does not affect performance radically











Nanoelectronics • Architectures



